31 N2 -600 T

FIG.7: Relative variations of gate trigger current, holding current and latching current versus junction temperature

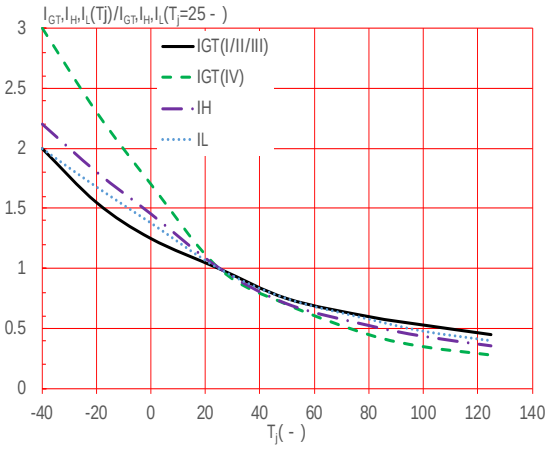
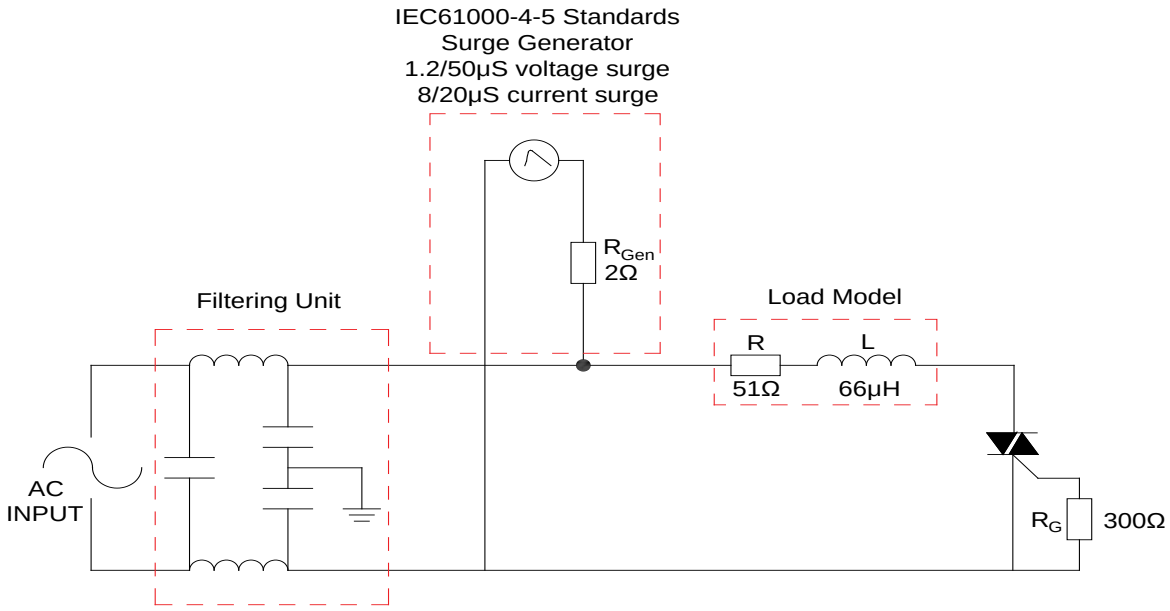
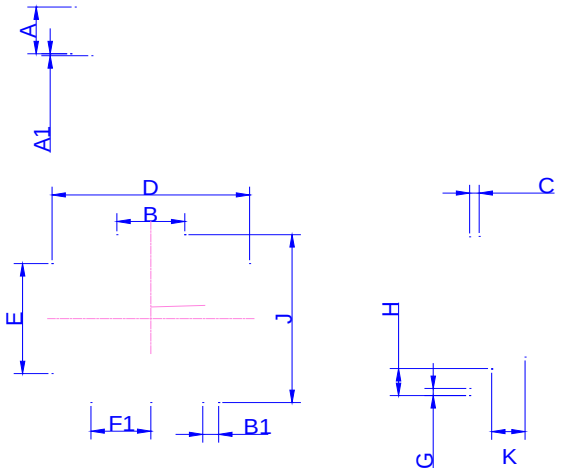


FIG.8 Test circuit for inductive and resistive loads to IEC-61000-4-5 standards



JST131N2-600T

PACKAGE MECHANICAL DATA



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